

Cambridge Assessment International Education

Cambridge International Advanced Subsidiary and Advanced Level

PHYSICS 9702/51

Paper 5 Planning, Analysis and Evaluation

May/June 2018

MARK SCHEME
Maximum Mark: 30

Published

This mark scheme is published as an aid to teachers and candidates, to indicate the requirements of the examination. It shows the basis on which Examiners were instructed to award marks. It does not indicate the details of the discussions that took place at an Examiners' meeting before marking began, which would have considered the acceptability of alternative answers.

Mark schemes should be read in conjunction with the question paper and the Principal Examiner Report for Teachers.

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Cambridge International AS/A Level – Mark Scheme

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Generic Marking Principles

These general marking principles must be applied by all examiners when marking candidate answers. They should be applied alongside the specific content of the mark scheme or generic level descriptors for a question. Each question paper and mark scheme will also comply with these marking principles.

GENERIC MARKING PRINCIPLE 1:

Marks must be awarded in line with:

- the specific content of the mark scheme or the generic level descriptors for the question
- the specific skills defined in the mark scheme or in the generic level descriptors for the question
- the standard of response required by a candidate as exemplified by the standardisation scripts.

GENERIC MARKING PRINCIPLE 2:

Marks awarded are always whole marks (not half marks, or other fractions).

GENERIC MARKING PRINCIPLE 3:

Marks must be awarded **positively**:

- marks are awarded for correct/valid answers, as defined in the mark scheme. However, credit is given for valid answers which go beyond the scope of the syllabus and mark scheme, referring to your Team Leader as appropriate
- marks are awarded when candidates clearly demonstrate what they know and can do
- marks are not deducted for errors
- marks are not deducted for omissions
- answers should only be judged on the quality of spelling, punctuation and grammar when these features are specifically assessed by the question as indicated by the mark scheme. The meaning, however, should be unambiguous.

GENERIC MARKING PRINCIPLE 4:

Rules must be applied consistently e.g. in situations where candidates have not followed instructions or in the application of generic level descriptors.

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GENERIC MARKING PRINCIPLE 5:

Marks should be awarded using the full range of marks defined in the mark scheme for the question (however; the use of the full mark range may be limited according to the quality of the candidate responses seen).

GENERIC MARKING PRINCIPLE 6:

Marks awarded are based solely on the requirements as defined in the mark scheme. Marks should not be awarded with grade thresholds or grade descriptors in mind.

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| Question | Answer | Marks |
|----------|---|-------|
| 1 | Defining the problem | |
| | V is the independent variable and F is the dependent variable or vary V and measure F . | 1 |
| | keep r constant | 1 |
| | Methods of data collection | |
| | labelled diagram of workable experiment including: T suspended (clamp or ceiling) S on top-pan balance vertically below T T and S labelled and at least one other label. | 1 |
| | F = difference/change in balance readings when sphere(s) (S) is uncharged and charged. | 1 |
| | voltmeter across a power supply (with flying lead) or read <i>V</i> from <u>high</u> voltage power supply/ <u>EHT</u> power supply | 1 |
| | measure r with a rule | 1 |
| | Method of analysis | |
| | plot a graph of F against V (allow valid log-log graphs) | 1 |
| | relationship valid if a straight line passing through the origin is produced | 1 |
| | α = gradient \times r^2 (consistent with graph) | 1 |

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| Question | | Answer | Marks | |
|----------|---|---|-------|--|
| | Additional detail including safety considerations | | | |
| | D1 | safety precaution linked to avoiding shock/ <u>high</u> voltages, e.g. <u>insulating</u> gloves to hold flying lead/to charge sphere/to avoid electrocution or use shrouded leads/ensure that there no bare connections/avoid touching metal parts | | |
| | D2 | use of <u>insulator</u> between sphere S and balance or between sphere T and stand | | |
| | D3 | discharge sphere(s) by earthing or connecting to the negative of the power supply | | |
| | D4 | additional detail to determine r e.g. determine radius of each sphere and add distance between spheres or measure from top of S to top of T etc. | | |
| | D5 | use of calipers/micrometer to measure diameter of spheres (and halve) to determine r or use of calipers/micrometer to measure diameter of spheres to check that spheres are the same diameter to determine r or use of fiducial mark and ruler from top of spheres etc. | | |
| | D6 | use of Δmg to determine F | | |
| | D7 | repeat experiment for each value of V and average F | | |
| | D8 | take reading of balance quickly to avoid discharge/keep other charged objects away | | |
| | D9 | method to ensure charge on S is constant, e.g. re-charge S periodically/regularly (with initial value of p.d.)/keep S connected to a separate positive terminal | | |
| | D10 | avoid draughts to prevent T moving | | |

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| Question | gradient = $\frac{1}{4N^2D^2}$ and y-intercept = $-\frac{1}{D^2}$ | | | | |
|-----------|--|--|--|----------|---|
| 2(a) | | | | | |
| 2(b) | | 5.4 or 5.41 | 2.6 or 2.60 | | 1 |
| | | 4.3 or 4.34 | 1.9 or 1.93 | | |
| | | 3.6 or 3.56 | 1.5 or 1.49 | | |
| | | 3.0 or 2.97 | 1.2 or 1.18 | | |
| | | 2.6 or 2.60 | 0.961 or 0.9612 | | |
| | | 2.3 or 2.30 | 0.826 or 0.8264 | | |
| | Uncertainties in 1/s² from : | \pm 0.16 or \pm 0.17 or \pm 0.18 or \pm 0.2 to | o ± 0.02 or ± 0.03. | | 1 |
| 2(c)(i) | Six points plotted correctly. Must be within half a small square. Diameter of points must be less than half a small square. | | | 1 | |
| | Error bars in 1/s² plotted c All error bars to be plotted. | | less than half a small square and symm | etrical. | 1 |
| 2(c)(ii) | Line of best fit drawn. Line does not pass through | n bottom point and line must pass b | etween (4.70, 2.2) and (4.85, 2.2). | | 1 |
| | Worst acceptable line draw All error bars must be plott | vn (steepest or shallowest possible ed. | line). | | 1 |
| 2(c)(iii) | Gradient determined with clear substitution of points from the line of best fit into $\Delta y/\Delta x$. Distance between points must be at least half the length of the drawn line. | | | 1 | |
| | Gradient of worst acceptab | ole line determined. | | | 1 |
| | • • | ne of best fit – gradient of worst acc | eptable line | | |
| | or uncertainty = ½ (steepest v | worst line gradient – shallowest wor | st line gradient) | | |

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| Question | Answer | Marks |
|----------|---|-------|
| 2(c)(iv) | y-intercept determined by substitution into $y = mx + c$. | 1 |
| | y-intercept determined using gradient from worst acceptable line. | 1 |
| | uncertainty = y-intercept of line of best fit – y-intercept of worst acceptable line or uncertainty = ½ (steepest worst line y-intercept – shallowest worst line y-intercept) | |
| 2(d)(i) | D determined using y-intercept and N determined using gradient. D and N given to 2 or 3 significant figures. | 1 |
| | D determined using y-intercept. $D = \frac{1}{\sqrt{-y\text{-intercept}}}$ | 1 |
| | N determined using gradient with correct power of ten and units. Correct substitution of numbers must be seen. $N = \sqrt{\frac{1}{4 \times \text{gradient} \times D^2}} \text{ or } \sqrt{\frac{-y \text{-intercept}}{4 \times \text{gradient}}}$ | 1 |
| 2(d)(ii) | $\sqrt{4 \times \text{gradient} \times D^2}$ $\sqrt{4 \times \text{gradient}}$ Percentage uncertainty in <i>N</i> determined. Correct substitution of numbers must be seen. | 1 |
| | % uncertainty in $N = \frac{1}{2}$ (% uncertainty in gradient + 2 × % uncertainty in D) or % uncertainty in $N = \frac{1}{2}$ (% uncertainty in gradient + % uncertainty in y -intercept) | |

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